ESTIMATING THE IMPUTED SOCIAL COST OF ERRORS OF
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ESTIMATING THE IMPUTED SOCIAL COST OF ERRORS OF MEASUREMENT

Frederic M. Lord

This research was sponsored in part by the Personnel and Training Research Programs Psychological Sciences Division Office of Naval Research, under Contract No. N00014-80-C-0402

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Frederic M. Lord, Principal Investigator

Educational Testing Service
Princeton, New Jersey

October 1983

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**Estimating the Imputed Social Cost of Errors of Measurement**

**Technical Report**

Frederic M. Lord

Educational Testing Service
Princeton, New Jersey 08541

Personnel and Training Research Programs
Office of Naval Research
Arlington, Virginia 22217

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Item Response Theory, Decision Theory, Test Design, Loss Function, Information Function, Item Selection

If a loss function is available specifying the social cost of an error of measurement in the score on a unidimensional test, an asymptotic method, based on item response theory, is developed for optimal test design for a specified target population of examinees. Since in the real world such loss functions are not available, it is more useful to reverse this process; thus a method is developed for finding the loss function for which a given test is an optimally designed test for the target population. An illustrative application is presented for one operational test.
Abstract

If a loss function is available specifying the social cost of an error of measurement in the score on a unidimensional test, an asymptotic method, based on item response theory, is developed for optimal test design for a specified target population of examinees. Since in the real world such loss functions are not available, it is more useful to reverse this process; thus a method is developed for finding the loss function for which a given test is an optimally designed test for the target population. An illustrative application is presented for one operational test.
Estimating the Imputed Social Cost of Errors of Measurement*

For a unidimensional test, the error of measurement is the difference between the examinee's true ability \( \theta \) and the estimate of this ability represented by the examinee's test score \( \hat{\theta} \). Since discrepancies between \( \hat{\theta} \) and \( \theta \) may lead to erroneous decisions about the examinee (misclassification, erroneous acceptance or rejection), there is an expected social cost associated with any pair of values \( (\hat{\theta}, \theta) \). This cost is given by some loss function \( L(\hat{\theta}, \theta) \).

The obvious problem, here called Problem 1, is: Given the loss function \( L(\hat{\theta}, \theta) \), how can we build an (optimal) \( n \)-item test that will minimize the expected loss over a specified target population of examinees, subject to certain constraints on the statistical characteristics of the items in the available item pool? Using item response theory, [Lord, 1980; Hulin, Drasgow, and Parsons, 1983], a solution of this problem will be given here for a unidimensional test.

Unfortunately, in practice it is unlikely that \( L(\hat{\theta}, \theta) \) will be known to the test designer. Something of practical value can still be salvaged, however, if we can deal with Problem 2: Given an existing unidimensional test and a specified target population of examinees, find the loss function \( L(\hat{\theta}, \theta) \) for which this test is an optimally designed test. If the

*The theoretical work in Sections 1-4 was supported by contract N00014-80-C-0402, project designation NR 150-453 between the Office of Naval Research and Educational Testing Service. The empirical work, using ETS data, was supported by ETS funds. The writer is very much indebted to Martha L. Stocking, who was responsible for obtaining the empirical results reported in Section 5.
loss function found for Problem 2 does not agree with our intuitive notions as to what is appropriate, we will probably redesign future test forms to avoid this discrepancy.

In order to solve Problem 2, it is necessary first to solve Problem 1; this is done in the first section. The solution to Problem 2 is outlined in the second section. Invariance under transformations of the ability scale is discussed in Section 3. In Section 4, a method for estimating the ability distribution of the target population is discussed. An illustrative application to an actual test is given in Section 5. The final section briefly discusses some implications for optimal test design.

It is assumed here that all item parameters have been determined by pretesting to sufficient accuracy so that they can be treated as known. The illustrative example and some of the discussion are based on the three-parameter logistic model of the item response function (with which the reader is assumed to be familiar), but the proofs of the main results are much more general. The examinee's actual score $\theta$ is assumed to be the maximum likelihood estimate of $\theta$, calculated from the examinee's responses to the $n$ test items.

1. Minimizing Expected Loss

For a group of examinees at a given ability level $\theta$, the conditional expected loss is by definition
where $\phi(\hat{\theta}|\theta)$ is the conditional distribution of \(\hat{\theta}\) and $\hat{\theta}$ denotes expectation. If the distribution of ability $\theta$ in the target population is denoted by $g(\theta)$, then the overall (unconditional) expected loss is by definition

$$\delta(L) = \int_{-\infty}^{\infty} \delta(L|\theta) g(\theta) \, d\theta. \quad (2)$$

This is the quantity to be minimized by optimal test design.

**Loss Function**

Certain reasonable assumptions will be made about the loss function:

1. $L(\hat{\theta},\theta) = 0$ (because when $\hat{\theta} = \theta$, there is no error of measurement and hence no loss due to error of measurement).

2. When $\hat{\theta} \neq \theta$, $L(\hat{\theta},\theta) > 0$.

3. When $\hat{\theta}$ is near $\theta$, the loss function and its first two derivatives with respect to $\hat{\theta}$ are continuous, the third derivative is bounded. [These conditions will guarantee the convergence of (3).]

4. The loss function does not change too sharply with changes in $\theta$ (as will be discussed later).

For fixed $\theta$, expand $L(\hat{\theta},\theta)$ in powers of $\hat{\theta} - \theta$, obtaining

$$L(\hat{\theta},\theta) = L(\theta,\theta) + (\hat{\theta} - \theta)L'(\theta,\theta) + \frac{1}{2} (\hat{\theta} - \theta)^2 L''(\theta,\theta) + \ldots$$
where \( L'(\hat{\theta},\theta) \) and \( L''(\hat{\theta},\theta) \) denote successive derivatives of \( L(\hat{\theta},\theta) \) with respect to \( \hat{\theta} \), evaluated at \( \hat{\theta} = \theta \). The first term vanishes because there is no error of measurement when \( \hat{\theta} = \theta \). The second term vanishes because for fixed \( \theta \), \( L(\hat{\theta},\theta) \) has a minimum at \( \hat{\theta} = \theta \). Consequently,

\[
L(\hat{\theta},\theta) = \frac{1}{2} (\hat{\theta} - \theta)^2 L''(\hat{\theta},\theta) \text{ plus higher order terms.} \tag{3}
\]

Higher powers of \((\hat{\theta} - \theta)\) can be neglected if \( n \) is not too small, since \( \hat{\theta} \to \theta \) in probability as \( n \to \infty \) [Lord, 1980, p. 59].

When (3) is substituted into (1), \( L''(\hat{\theta},\theta) \) comes out from under the integration sign. It is then apparent that asymptotically (that is, for large \( n \))

\[
\delta(L \mid \theta) = \frac{1}{2} L''(\hat{\theta},\theta) \text{ Var}(\hat{\theta} \mid \theta) \tag{4}
\]

In item response theory, the asymptotic (conditional) variance of \( \hat{\theta} \) is the reciprocal of the test information function \( I(\theta) \) [Lord, 1980, Section 5.3]. Thus we shall rewrite the expected loss (2) as

\[
\delta(L) = \frac{1}{2} \int_{-\infty}^{\infty} \frac{L''(\hat{\theta},\theta) g(\theta)}{I(\theta)} \, d\theta \tag{5}
\]

**Information Function**

The item response function \( P_i = P_i(\theta) \) is the probability of a correct response to item 1 by a randomly chosen examinee at ability level \( \theta \). The information function is
Imputed Social Cost

\[ I(\theta) = \frac{1}{\text{Var}(\theta|\theta)} = \sum_{i=1}^{n} \frac{P_i^2}{P_i Q_i} \]  

(6)

where \( Q_i = 1 - P_i \) and \( P_i' = \frac{dP_i}{d\theta} \).

Ordinarily \( P_i \) depends on an item difficulty parameter \( b_i \). Furthermore, \( b_i \) is typically simply a translation parameter: it affects \( P_i \) only through the difference \( \theta - b_i \). In this standard situation, \( b_i \) also affects \( P_i' \) only through the difference \( \theta - b_i \). Thus the area under any function \( F \) of \( P_i \) and \( P_i' \) over the whole range of \( \theta \)

\[ \int_{-\infty}^{\infty} F(\theta - b_i) d\theta = \int_{-\infty}^{\infty} F(\theta) d\theta \]

is independent of \( b_i \). The area under the test information function thus does not depend on \( b_i \) in these typical models, which will be assumed here.

In the special case where \( P_i(\theta) \) is the three-parameter logistic function

\[ P_i(\theta) = c_i + \frac{1 - c_i}{1 + \exp[-1.7a_i(\theta - b_i)]} \]  

(7)

we have

\[ P_i' = \frac{1.7a_i}{1 - c_i} Q_i(P_i - c_i) \]
and

\[ \int_{-\infty}^{\infty} I(\theta) \, d\theta = \int_{-\infty}^{\infty} \sum_{i} \frac{1}{P_i Q_i} \, d\theta = \int_{-\infty}^{\infty} \sum_{i} \frac{P'_i}{P_i Q_i} \, d\theta = \int_{-\infty}^{\infty} \sum_{i} \frac{1}{c_i} \, dP_i \]

\[ = \sum_{i} \frac{1.7a}{1 - c_i} \int (1 - \frac{c_i}{P_i}) \, dP_i = \sum_{i} \frac{1.7a_i}{1 - c_i} [P_i - c_i \log P_i]_i \]

\[ = \sum_{i=1}^{n} \frac{1.7a_i}{1 - c_i} (1 - c_i + c_i \log c_i) \quad . \quad (8) \]

This area does not depend on \( b_i \).

**Test Constraints**

There are always constraints on the availability of items for test construction. Item writers can control to a considerable extent the difficulty level of the items they write. The discriminating power of the available items, however, can ordinarily be increased only by writing more items and then discarding a larger percentage of the items written—an expensive procedure.

It will be assumed here that the test developer has available an unlimited pool of items at whatever difficulty levels he or she may specify. The items in the pool have already been pretested; faulty items, especially those with low discriminating power, have already been discarded. The test developer is to build parallel forms of a test from the item pool, selecting items only on the basis of their difficulty \( b_i \),
so that each parallel form has the same distribution of $b_i$. Items cannot be selected on the basis of their discriminating power, since all items not discarded after pretesting must eventually be used. In the actual test produced, the frequency distribution of other item parameters, such as item discriminating power, is to be the same as in the total pool of pretested items. It will be assumed here that in the item pool the distribution of other item parameters is independent of the item difficulty $b_i$. This assumption should be checked empirically for any practical application.

This assumption may fail to hold because of the essential nature of the test items; often it also fails to hold simply because pretest item-test biserials have been used instead of the IRT discrimination parameter $a_i$ to exclude poorly discriminating items from the available item pool. When item-test biserials are used in this way for multiple-choice items, the harder the item, the higher the $a_i$ parameter must be for the item to escape exclusion from the item pool. This is true because among items with identical $a_i$, the more guessing the lower the item-test biserial.

It follows from these assumptions that the total area under the test information function is fixed. The task of the test developer is to minimize $\delta(L)$ by choice of $b_i$ ($i = 1, 2, \ldots, n$); no other relevant variables are available to the test developer for achieving this minimization.

**Minimization**

By the Cauchy inequality,

$$\int \frac{L}{g} \cdot \int I \geq (\int \sqrt{L} g)^2.$$
Here, the first integral is twice the expected loss (5) written in abbreviated notation. Transposing, we have

\[ \int \frac{L''(\theta)}{I} \geq \left( \int \frac{L''(\theta)}{g(\theta)} \right)^2 \cdot I \]  

(9)

In Problem 1, \( L''(\theta, \theta) \) and \( g(\theta) \) are known; furthermore \( \int_{-\infty}^{\infty} I(\theta) \, d\theta \) is fixed by the reasoning of the last two subsections. It follows that if there is an \( I(\theta) \) such that equality holds in (9), then this is the \( I(\theta) \) that minimizes the expected loss (5). Equality will hold in (9) provided

\[ I(\theta) \text{ is proportional to } \sqrt{L''(\theta, \theta) \, g(\theta)} \]

Monetary Units

The loss function \( L(\hat{\theta}, \theta) \) is necessarily expressed in terms of some arbitrary unit (dollar, peso, ...). It may be convenient to choose this unit so that the area under \( \sqrt{L''(\theta, \theta) \, g(\theta)} \) is equal to \( \int_{-\infty}^{\infty} I(\theta) \, d\theta \), this last being a known and fixed quantity determined by \( n \) and by the item parameters, excluding the \( b_i \), of the item pool. Once this choice of unit has been made, the expected loss will be minimized if the test developer can build a test with

\[ I(\theta) = \sqrt{L''(\theta, \theta) \, g(\theta)} \]  

(10)
Building the Test

Birnbaum [1968, Section 20.6] suggested an effective cut-and-try method for building a test having (approximately) a prespecified 'target' information function. The method is outlined in Lord [1980, Section 5.4]. The method follows easily from the fact that the test information function is simply a sum of the information functions \( (p_i^2 / \pi Q_i) \) of the items included in the test.

The method is effective provided the target information curve is not too irregular and does not vary too rapidly as a function of \( \theta \). The results obtained here hold under this condition. If the target curve is too irregular, it will not be possible to build a test having the desired information function by selecting items on \( b_i \) from the available item pool.

Practical Procedure (Summary)

Given \( L(\theta, \theta) \) and \( g(\theta) \), to build \( k \) parallel test forms of length \( n \) that approximately minimize the expected loss:

1. Plot \( a_i \) and \( c_i \) against \( b_i \) to verify that the distribution of \( a_i \) and \( c_i \) in the item pool is approximately the same at all levels of \( b_i \), as assumed in the subsection titled Test Constraints.

2. Compute

\[
\int_{-\infty}^{\infty} I(\theta) \, d\theta = \frac{n}{M} \quad \int_{i=1}^{M} \frac{P_i^2}{\pi Q_i} \, d\theta
\]

where \( M \) is the number of items in a large item pool. Note that this integral does not depend on the distribution of \( b_i \) in the pool.
3. Choose monetary units so that

$$\int_{-\infty}^{\infty} \sqrt{L''(\theta, \theta) g(\theta)} \ d\theta$$

is equal to

$$k \int_{-\infty}^{\infty} I(\theta) \ d\theta$$

for some integer $k$.

4. Selecting items only on their $b_i$, use Birnbaum's method to select a pool of $nk$ items such that the sum of the $nk$ item information functions is approximately equal to

$$\sqrt{L''(\theta, \theta) g(\theta)}$$

5. Divide the $nk$ selected items into $k$ test forms of $n$ items each, all approximately parallel to each other.

2. The Loss Function for Which a Given Test Is an Optimal Test

If a given test is an optimal test, then (10) holds and

$$L''(\theta, \theta) = \frac{I^2(\theta)}{g(\theta)} \quad (11)$$

Consequently, the loss function is given approximately by (3) and (11):

$$L(\hat{\theta}, \theta) = \frac{1}{2} \frac{I^2(\theta)}{g(\theta)} (\hat{\theta} - \theta)^2 \quad (12)$$
For fixed $\hat{\theta}$, this is the equation of a parabola. When $n$ is not too small, $\hat{\theta}$ will be close to $\theta$ and (12) will provide an adequate approximation to the loss function for those values of $\hat{\theta}$ that are likely to be observed. For $\hat{\theta}$ close to $\theta$, the desired loss function can be computed from (12) for any given test, provided $g(\cdot)$ is specified.

3. Transformation of the Score Scale

Loss functions have an invariance property that is important in dealing with problems of test design. Consider the social cost in dollars of an error of measurement at a given ability level. If the error of measurement (the discrepancy between the actual test score and the true ability of which it is an estimate) is specified as a multiple of its standard error, asymptotically (for large $n$) the loss in dollars will be the same no matter what scale is used for measuring ability.

Instead of using the $\theta$ scale of ability, suppose we use the number-right true-score scale, given by the monotonic continuous transformation

$$\xi = \sum_{i=1}^{n} P_i(\theta) \quad .$$

(13)

The examinee's obtained score should now be taken to be

$$\xi = \sum_{i=1}^{n} P_i(\hat{\xi}) \quad .$$

(14)
Imputed Social Cost

(Note that we need to use here the maximum likelihood estimator of $\xi$ defined by (14), not the examinee's number of right answers.) If $\hat{\theta}$ differs from $\theta$ by $K$ times $\text{S.E.}(\hat{\theta} | \theta)$, then, asymptotically, $\hat{\xi}$ will differ from $\xi$ by $K$ times $\text{S.E.}(\hat{\xi} | \xi)$. Asymptotically, $K[\text{S.E.}(\hat{\theta} | \theta)]$ is actually the same error of measurement on the $\theta$ scale as $K[\text{S.E.}(\hat{\xi} | \xi)]$ is on the $\xi$ scale; thus the social consequences of this error will be the same regardless of the scale used.

Let $\theta(\xi)$ denote the inverse of transformation (13). Expressed on the $\xi$ scale, the loss function (12) becomes

$$L_\xi(\hat{\xi}, \xi) = \frac{1}{2} \frac{\int_0^1 [\theta(\xi)]^2}{g(\theta(\xi))} [\theta(\hat{\xi}) - \theta(\xi)]^2$$

where $g(\ )$ and $I(\ )$ denote the same functions as previously. This equation could be used as it stands, but for reasons of symmetry, it may be preferable to expand it for fixed $\xi$ in powers of $\hat{\xi} - \xi$. The result is found to be

$$L_\xi(\hat{\xi}, \xi) = \frac{1}{2} \frac{\int_0^1 [\theta(\xi)]^2}{g(\theta(\xi))} \left[ \frac{d\theta(\xi)}{d\xi} \right]^2 (\hat{\xi} - \xi)^2.$$  \hspace{1cm} (15)

Equation (15) is used here to represent the loss function when the obtained score is $\hat{\xi}$ rather than $\hat{\theta}$. This transformation has an advantage for presenting experimental results, since the number-right score scale is more familiar to us than the $\theta$ scale.
Note again that the actual monetary loss is the same regardless of the scale against which it is plotted. This invariance makes the loss function much more useful for guiding test design than the information function. Expressed on the $\theta$ scale, the test information function for $\theta$ is typically a bell-shaped curve; expressed on the $\xi$ scale, the test information function for $\xi$ is necessarily a U-shaped curve [Lord, 1980, Chapter 6]. This lack of invariance makes it difficult to use the test information function as a convincing basis for test design.

4. Estimating the True $g(\theta)$

By its definition, expected loss (2) requires specification of the distribution $\theta$ in the target population. It is important to note that the distribution of $\hat{\theta}$ in the target population is not an adequate estimate of $g(\theta)$, the true distribution of $\theta$. The reason is that $\hat{\theta}$ contains errors of measurement and thus has a larger variance than $\theta$. Since $g(\theta)$ appears in the denominator of (12), it is particularly important to estimate $g(\theta)$ as accurately as possible.

To obtain the numerical results of Section 5, the true distribution of number-right true score (13), here denoted by $f(\xi)$, was estimated by Method 20 [Lord, 1980, Chapter 16]. Since $\xi$ is necessarily $\geq E_4 P_4(-\infty)$, an estimated lower limit for $\xi$ was set at $E_4 \hat{c}_1$, where $\hat{c}_1$ represents the estimated $c$ parameter of item $i$. For purposes of Section 5 all
item parameters were estimated under the three-parameter logistic model (7) by the computer program LOGIST [Note 1].

The required estimate of $g(\theta)$ for the target population was obtained from the Method 20 estimate of $f(\xi)$ by the relation

$$g(\theta) = f(\xi) \frac{d\xi}{d\theta}.$$  \hspace{1cm} (16)

The derivative in (16) is the derivative of (13), estimated in practice by computing $\sum_{i=1}^{n} P'(\theta)$ from estimated item parameters.

5. Illustrative Example

A representative sample of 19,949 examinees tested in 1981-82 was obtained for the Sentence Sense test in Form 3EJP of the New Jersey College Basic Skills Placement Test. This competency test consists of 35 four-choice items requiring the examinee to distinguish correct from incorrect English expression. The test is used primarily to assign certain entering college students to remedial English classes.

The item responses of all 19,949 examinees were analyzed, using LOGIST to estimate the item parameters of all items in the test. The true distribution of $\theta$ for the target population was estimated as described in Section 4 (for this purpose, a response chosen at random from the four choices was supplied wherever an examinee failed to respond to an item). The test information function (6) was calculated from the estimated item parameters. Finally, the loss function for which the test is an optimally designed test was estimated by (12).
Figure 1 shows the actual distribution of number-right scores (frequency polygon), the number-right true-score distribution estimated by Method 20 (solid curve), and the corresponding fitted distribution of (observed) number-right scores (dotted curve). The modal score is 31 right answers out of a possible 35. The chi square between observed and fitted number-right score distributions is at the 86th percentile of the chi square distribution with 18 degrees of freedom. In view of the large sample size (N = 19,949), this seems an adequate fit, as in indeed suggested visually by the agreement shown in Figure 1.

The estimated loss function (12) for which the test is an optimally designed test is plotted in Figure 2 against the \( \hat{\theta} \) and \( \Theta \) Scales. The direction of the \( \hat{\theta} \) scale is reversed from the conventional direction in order to improve visibility. Loss is shown on the vertical scale. In this and the next figure, the parabola for any given \( \theta \) is drawn only for \( \hat{\theta} \) values within two standard errors of the true \( \theta \).

The figure shows that the Sentence Sense test is built as if it were important to measure accurately at high ability levels as well as at low ability levels. Clearly, this is not appropriate for a competency test—the test should assign high losses to errors of measurement at low ability levels but not at high ability levels. The more difficult items in the test should be replaced by easier items.

The estimated loss function (15) for which the test is an optimally designed test is plotted in Figure 3 against number-right true score and
Figure 1. Frequency distributions of true and observed number-right scores for NJCBSPT Sentence Sense, Form 3EJP, N = 19949.
Figure 2. Loss function for NJBSCPT, 3EJP, Sentence Sense, $N = 19949$. 
Figure 3. Estimated Loss Function for NJBSCT, 3EJP, Sentence Sense, $N = 19949$, as a function of true score ($\xi$) and estimated true score ($\hat{\xi}$).
estimated number-right true score. For ease of viewing, both scales at the bottom of the figure run in the opposite direction from the scales at the bottom of Figure 2. This plot is easier to interpret than Figure 2 since we are more accustomed to the number-right score scale than to the \( \theta \) scale. The plot looks very different from Figure 2 because

1. The loss function for a number-right score of 34 is not shown. The loss function for this score is rather high and would obscure too much of the rest of the figure.

2. A wide range at the high end of the \( \theta \) scale is compressed into a small range of number-right scores, as shown in the following table:

\[
\begin{array}{cccccccccccccc}
\xi & : & 8 & 10 & 12 & 14 & 16 & 18 & 20 & 22 & 24 & 26 & 28 & 30 & 32 & 34 \\
\theta & : & -5.2 & -3.1 & -2.4 & -1.9 & -1.6 & -1.3 & -1.0 & -.7 & -.4 & -.2 & .1 & .5 & 1.0 & 2.1 \\
\end{array}
\]

Again, it appears that the test discriminates at high true score levels, where discrimination is not really desired. The loss function at \( \xi = 34 \) (not plotted) shows a loss of approximately 100 when \( \hat{\xi} \) is two standard errors from \( \xi \). For number-right scores of 30 and below, the shape of the loss function seems very appropriate for a competency test, with very high losses attributed to errors of measurement at low score levels.
6. Discussion

In the case of a minimum competency test, the social losses arising from errors of measurement will be high for examinees near the cutting score, which is always near the low end of the score scale. Social losses will be near zero for examinees far from the cutting score, since decisions about these examinees will not be changed by small errors in their scores.

For a college admissions test, it would seem reasonable to expect that errors of measurement in the scores of high ability students will result in relatively high social losses. Somewhat lower social losses should be expected to result from errors in the scores of low ability students.

In the case of grade school tests of 'ability' or of vocabulary, it has sometimes been argued that, to be fair, the standard error of measurement of the test score should be roughly the same for each individual (see, for example, Hulin et al., 1983, p. 90). The first difficulty with this approach is that its implications for test design when the test score is $\hat{\theta}$ are completely different than when the test score is $\hat{\xi}$ or simply the number of right answers. Although equality of standard errors of measurement at all ability levels has strong intuitive appeal, there is no clear way to decide whether this equality should hold on the $\theta$ scale, or on the number-right score scale, or on some other scale. It cannot hold simultaneously on two different scales unless one scale is a linear transformation of the other.
In any case, any goal of equal standard errors of measurement at different ability levels is completely incompatible with the goal of minimizing expected social loss due to errors of measurement. If we wish to minimize social loss, we must, other things being equal, mobilize our test development resources so as to measure most accurately at those ability levels where the most people are found. We cannot waste items in order to secure accurate measurement at ability levels where only a few people will be affected, unless, of course, there is a very high loss function at these ability levels. In a word, accuracy of measurement in sparsely populated stretches of the ability range must be sacrificed, other things being equal, in order to obtain more accurate measurement in heavily populated stretches.

As a concrete example, consider a vocabulary test for grade 5 and suppose our test is built to minimize overall expected loss. Suppose also, as might be reasonable for such a test, that the expected loss at a fixed ability level is constant across ability levels, so that, by (12),

$$\delta[L(\hat{\theta}, \theta) | \theta] = \frac{1}{2} \frac{I^2(\theta)}{g(\theta)} \delta[(\hat{\theta} - \theta)^2 | \theta] = \frac{1}{2} \frac{I^2(\theta)}{g(\theta)} \frac{1}{I(\theta)} = K$$

where $K$ is some constant. It follows that

$$\text{Var}(\hat{\theta} | \theta) = \frac{1}{I(\theta)} = \frac{1}{2Kg(\theta)}$$
Since \( g(\theta) \) is small for extreme \( \theta \), the standard error of measurement, \( \sqrt{\text{Var}(\theta|\theta)} \), will in this case be very much larger for examinees with extreme \( \theta \) than for examinees with moderate \( \theta \). Thus in this case the goal of equal standard errors of measurement at all ability levels is utterly incompatible with minimizing overall expected loss. This is simply an illustration of the fact that if we wish to minimize overall expected loss, our measurement effort must be concentrated on the sub-ranges of ability that are most highly populated in the target population.

To summarize, in respect to a unidimensional test:

1. Given the loss function, the distribution of ability in a target population, and certain constraints on the available item pool, a method has been described for designing a test that will minimize expected loss.

2. Given a test and also the distribution of ability in the target population, a method has been described for finding the loss function for which this test is an optimally designed test given certain constraints on the available item pool.

3. Minimizing social loss is in general incompatible with equal measurement accuracy across examinees. To minimize social loss, measurement accuracy must be high (other things being equal) over ability ranges that are heavily populated, and relatively low over ranges that are sparsely populated.
Reference Note

Wingersky, M. S., Barton, M. A., & Lord, F. M. *LOGIST user's guide.*

References


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<td>Dr. Robert Breaux</td>
<td>NAVTRAEBOPCEN Code N-095R Orlando, FL 32813</td>
</tr>
<tr>
<td>Dr. Robert Carroll</td>
<td>NAVOP 115 Washington, DC 20370</td>
</tr>
<tr>
<td>Chief of Naval Education and Training Liaison Office Air Force Human Resource Laboratory Flying Training Division Williams Air Force Base, AZ 85224</td>
<td></td>
</tr>
<tr>
<td>Dr. Stanley Collyer</td>
<td>Office of Naval Technology 800 N. Quincy Street Arlington, VA 22217</td>
</tr>
<tr>
<td>CDR Mike Curran</td>
<td>Office of Naval Research 800 North Quincy Street Code 270 Arlington, VA 22217</td>
</tr>
<tr>
<td>Dr. Tom Duffy</td>
<td>Navy Personnel R&amp;D Center San Diego, CA 92152</td>
</tr>
<tr>
<td>Mr. Mike Durmeyer</td>
<td>Instructional Program Development Building 90 NET-PDCD Great Lakes NTC, IL 60088</td>
</tr>
<tr>
<td>Dr. Richard Elster</td>
<td>Department of Administrative Sciences Naval Postgraduate School Monterey, CA 93940</td>
</tr>
<tr>
<td>Dr. Pat Federico</td>
<td>Navy Personnel R &amp; D Center San Diego, CA 92152</td>
</tr>
<tr>
<td>Dr. Cathy Fernandes</td>
<td>Navy Personnel R &amp; D Center San Diego, CA 92152</td>
</tr>
<tr>
<td>Dr. John Ford</td>
<td>Navy Personnel R &amp; D Center San Diego, CA 92152</td>
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<tr>
<td>Dr. Jim Hollan</td>
<td>Navy Personnel R &amp; D Center San Diego, CA 92152</td>
</tr>
<tr>
<td>Dr. Ed Hutchins</td>
<td>Navy Personnel R &amp; D Center San Diego, CA 92152</td>
</tr>
</tbody>
</table>
1 Dr. Norman J. Kerr
Chief of Naval Technical Training
Naval Air Station Memphis (75)
Millington, TN 38054

1 Dr. Peter Kincaid
Training Analysis & Evaluation Group
Department of the Navy
Orlando, FL 32813

1 Dr. R. W. King
Director, Naval Education
and Training Program
Naval Training Center, Bldg. 90
Great Lakes, IL 60088

1 Dr. Leonard Kroeker
Navy Personnel R & D Center
San Diego, CA 92152

1 Dr. William L. Maloy (02)
Chief of Naval Education and Training
Naval Air Station
Pensacola, FL 32508

1 Dr. Kneale Marshall
Chairman, Operations Research Dept.
Naval Post Graduate School
Monterey, CA 93940

1 Dr. James McBride
Navy Personnel R & D Center
San Diego, CA 92152

1 Dr. William Montague
KPRDC Code 13
San Diego, CA 92152

1 Mr. William Nordbrock
1032 Fairlawn Avenue
Libertyville, IL 60048

1 Library, Code P201L
Navy Personnel R & D Center
San Diego, CA 92152

1 Technical Director
Navy Personnel R & D Center
San Diego, CA 92152

6 Personnel & Training Research Group
Code 442PT
Office of Naval Research
Arlington, VA 22217

1 Special Asst. for Education and
Training (OP-01E)
Room 2705 Arlington Annex
Washington, DC 20370

1 LT Frank C. Petho, MSC, USN
CNET (N-432)
NAS
Pensacola, FL 32508

1 Dr. Bernard Rimland (01C)
Navy Personnel R & D Center
San Diego, CA 92152

1 Dr. Carl Ross
CNET-PDCD
Building 90
Great Lakes NTC, IL 60088

1 Dr. Worth Scanland, Director
CNET (N-5)
NAS
Pensacola, FL 32508

1 Dr. Robert G. Smith
Office of Chief of Naval Operations
OP-987H
Washington, DC 20350

1 Dr. Alfred F. Smode, Director
Training Analysis and Evaluation Group
Department of the Navy
Orlando, FL 32813

1 Dr. Richard Sorensen
Navy Personnel R & D Center
San Diego, CA 92152
<table>
<thead>
<tr>
<th>Name</th>
<th>Position</th>
<th>Address</th>
</tr>
</thead>
<tbody>
<tr>
<td>1 Dr. Frederick Steinheiser</td>
<td>Director, Office of Manpower Utilization</td>
<td>CNO - OP115</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Navy Annex</td>
</tr>
<tr>
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<td>Arlington, VA 20370</td>
</tr>
<tr>
<td>1 Mr. Brad Sympson</td>
<td>Headquarters, U. S. Marine Corps</td>
<td>Naval Personel R &amp; D Center</td>
</tr>
<tr>
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<td>San Diego, CA 92152</td>
</tr>
<tr>
<td>1 Dr. Frank Vicino</td>
<td>Special Assistant for Marine Corps Matters</td>
<td>Navy Personel R &amp; D Center</td>
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<tr>
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<td>San Diego, CA 92152</td>
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<tr>
<td>1 Dr. Edward Wegman</td>
<td>Technical Director</td>
<td>Office of Naval Research (Code 411S&amp;P)</td>
</tr>
<tr>
<td></td>
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<td>800 North Quincy Street</td>
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<td>Arlington, VA 22217</td>
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<tr>
<td>1 Dr. Ronald Weitzman</td>
<td>Army</td>
<td>Code 54 WZ</td>
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<td>U.S. Naval Postgraduate School</td>
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<td>Monterey, CA 93940</td>
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<tr>
<td>1 Dr. Douglas Wetzel</td>
<td>Major Frank Yohannan, USMC</td>
<td>Code 12</td>
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<td>San Diego, CA 92152</td>
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<tr>
<td>1 Dr. Martin F. Wiskoff</td>
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<td>Mr. James Baker</td>
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<td>Alexandria, VA 22333</td>
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<tr>
<td>1 Mr. John H. Wolfe</td>
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<td>Mr. James Baker</td>
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<tr>
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<td>Alexandria, VA 22333</td>
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<tr>
<td>1 Dr. Wallace Wulfeck, III</td>
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<td>Mr. James Baker</td>
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<td>Alexandria, VA 22333</td>
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<tr>
<td>1 Dr. H. William Greenup</td>
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<td>Dr. Kent Eaton</td>
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<td>Alexandria, VA 22333</td>
</tr>
</tbody>
</table>
Army

1 Dr. Beatrice J. Farr
U.S. Army Research Institute
5001 Eisenhower Avenue
Alexandria, VA 22333

1 Dr. Joyce Shields
U.S. Army Research Institute
5001 Eisenhower Avenue
Alexandria, VA 22333

1 Dr. Myron Fischl
U.S. Army Research Institute for the
Social and Behavioral Sciences
5001 Eisenhower Avenue
Alexandria, VA 22333

1 Dr. Hilda Wing
U.S. Army Research Institute
5001 Eisenhower Avenue
Alexandria, VA 22333

1 Dr. Robert Wisher
U.S. Army Research Institute
5001 Eisenhower Avenue
Alexandria, VA 22333

Air Force

1 Air Force Human Resources Laboratory
AFIRL/MPD
Brooks Air Force Base, TX 78235

1 Technical Documents Center
Air Force Human Resources Laboratory
WPAFB, OH 45433

1 U.S. Air Force Office of
Scientific Research
Life Sciences Directorate, NL
Bolling Air Force Base
Washington, DC 20332

1 Air University Library
AUL/LSE 76/443
Maxwell AFB, AL 36112

1 Dr. Earl A. Alluisi
HQ, AFHRL (AFSC)
Brooks Air Force Base, TX 78235

1 Dr. Raymond E. Christal
AFHRL/MOE
Brooks AFB, TX 78235

1 Dr. Alfred R. Fregly
AFOSR/NL
Bolling AFB, DC 20332
Air Force

1 Dr. Genevieve Haddad  
Program Manager  
Life Sciences Directorate  
AFOSR  
Boiling AFB, DC 20332

1 Dr. T. M. Longridge  
AFHRL/OTE  
Williams AFB, AZ 85224

1 Dr. Roger Pennell  
Air Force Human Resources Laboratory  
Lowry AFB, CO 80230

1 Dr. Malcolm Ree  
AFHRL/HP  
Brooks Air Force Base, TX 78235

1 LT Tallarigo  
3700 TCHTW/TTCRR  
Sheppard AFB, TX 76311

1 Dr. Joseph Yasatuke  
AFHRL/LRT  
Lowry AFB, CO 80230

Department of Defense

1 Mr. Jerry Lehnus  
HQ MEPCOM  
Attn: MEPCT-P  
Ft. Sheridan, IL 60037

1 Military Assistant for Training  
and Personnel Technology  
Office of the Under Secretary of  
Defense for Research and Engineering  
Room 3D129, The Pentagon  
Washington, DC 20301

1 Dr. Wayne Sellman  
Office of the Assistant Secretary  
of Defense (HRA&L)  
2B269 The Pentagon  
Washington, DC 20301

1 Major Jack Thorpe  
DARPA  
1400 Wilson Blvd.  
Arlington, VA 22209

Civilian Agencies

1 Dr. Craig I. Fields  
Advanced Research Projects Agency  
1400 Wilson Blvd.  
Arlington, VA 22209

1 Dr. William Graham  
Testing Directorate  
MEPCON/MEPCT-P  
Ft. Sheridan, IL 60037

1 Dr. Patricia A. Butler  
NIE-BRN Bldg., Stop #7  
1200 19th Street, NW  
Washington, DC 20208

1 Dr. Susan Chipman  
Learning and Development  
National Institute of Education  
1200 19th Street NW  
Washington, DC 20208

1 Dr. Arthur Helmed  
724 Brown  
U.S. Department of Education  
Washington, DC 20208

1 Dr. Andrew R. Molnar  
Office of Scientific and Engineering  
Personnel and Education  
National Science Foundation  
Washington, DC 20550
Civilian Agencies

1 Dr. Vern W. Urry
Personnel R & D Center
Office of Personnel Management
1900 E Street, NW
Washington, DC 20415

1 Mr. Thomas A. Warm
U.S. Coast Guard Institute
P.O. Substation 18
Oklahoma City, OK 73169

1 Dr. Frank Withrow
U.S. Office of Education
400 Maryland Avenue, SW
Washington, DC 20202

1 Dr. Joseph L. Young, Director
Memory and Cognitive Processes
National Science Foundation
Washington, DC 20550

Private Sector

1 Dr. James Algina
University of Florida
Gainesville, FL 32611

1 Dr. Patricia Baggett
Department of Psychology
University of Colorado
Boulder, CO 80309

1 Dr. Isaac Bejar
Educational Testing Service
Princeton, NJ 08541

1 Dr. Menucha Birenbaum
School of Education
Tel Aviv University
Tel Aviv, Ramat Aviv 69978
ISRAEL

1 Dr. R. Darrell Bock
Department of Education
University of Chicago
Chicago, IL 60637

1 Dr. Robert Brennan
American College Testing Programs
P.O. Box 168
Iowa City, IA 52243

1 Dr. Glenn Bryan
6208 Poe Road
Bethesda, MD 20817

1 Dr. Ernest R. Cadotte
307 Stokely
University of Tennessee
Knoxville, TN 37916

1 Dr. Pat Carpenter
Department of Psychology
Carnegie-Mellon University
Pittsburgh, PA 15213

1 Dr. John B. Carroll
409 Elliott Road
Chapel Hill, NC 27514

1 Dr. Norman Cliff
Department of Psychology
University of Southern California
University Park
Los Angeles, CA 90007

1 Dr. Allan M. Collins
Bolt, Beranek, and Newman, Inc.
50 Moulton Street
Cambridge, MA 02138

1 Dr. Lynn A. Cooper
LRDC
University of Pittsburgh
3939 O'Hara Street
Pittsburgh, PA 15213
Private Sector

1 Dr. Hans Crombag
Education Research Center
University of Leyden
Boerhaavelaan 2
2334 EN Leyden
THE NETHERLANDS

1 Dr. Dattpradad Divgi
Syracuse University
Department of Psychology
Syracuse, NY 3210

1 Dr. Susan Emberton
Psychology Department
University of Kansas
Lawrence, KS 66045

1 ERIC Facility-Acquisitions
4833 Rugby Avenue
Bethesda, MD 20014

1 Dr. Benjamin A. Fairbank, Jr.
McFann-Gray and Associates, Inc.
5825 Callaghan
Suite 225
San Antonio, TX 78228

1 Dr. Leonard Feldt
Lindquist Center for Measurement
University of Iowa
Iowa City, IA 52242

1 Prof. Donald Fitzgerald
University of New England
Armidale, New South Wales 2351
AUSTRALIA

1 Dr. Dexter Fletcher
WICAT Research Institute
1875 S. State Street
Orem, UT 22333

1 Dr. John R. Frederiksen
Bolt, Beranek, and Newman
50 Moulton Street
Cambridge, MA 02138

---

Private Sector

1 Dr. Janice Gifford
University of Massachusetts
School of Education
Amherst, MA 01002

1 Dr. Robert Glaser
LRDC
University of Pittsburgh
3939 O'Hara Street
Pittsburgh, PA 15213

1 Dr. Bert Green
Department of Psychology
Johns Hopkins University
Charles and 34th Streets
Baltimore, MD 21218

1 Dr. Ron Hambleton
School of Education
University of Massachusetts
Amherst, MA 01002

1 Dr. Paul Horst
677 G Street, #184
Chula Vista, CA 90010

1 Dr. Lloyd Humphreys
Department of Psychology
University of Illinois
Champaign, IL 61820

1 Dr. Jack Hunter
2122 Coolidge Street
Lansing, MI 48906

1 Dr. Huynh Huynh
College of Education
University of South Carolina
Columbia, SC 29208

1 Dr. Douglas H. Jones
10 Trafalgar Court
Lawrenceville, NJ 08648
Private Sector

1 Prof. John A. Keats
Department of Psychology
University of Newcastle
Newcastle, New South Wales 2308
AUSTRALIA

1 Dr. William Koch
University of Texas-Austin
measurement and Evaluation Center
Austin, TX 78703

1 Dr. Pat Langley
The Robotics Institute
Carnegie-Mellon University
Pittsburgh, PA 15213

1 Dr. Alan Lesgold
Learning R & D Center
University of Pittsburgh
3939 O'Hara Street
Pittsburgh, PA 15260

1 Dr. Michael Levine
Department of Educational Psychology
210 Education Building
University of Illinois
Champaign, IL 61801

1 Dr. Charles Lewis
Faculteit Sociale Wetenschappen
Rijksuniversiteit Groningen
Oude Boteringestraat 23
9712CG Groningen
NETHERLANDS

1 Dr. Robert Linn
College of Education
University of Illinois
Urbana, IL 61801

1 Mr. Phillip Livingston
Systems and Applied Sciences Corporation
66111 Kenilworth Avenue
Riverdale, MD 20840

Private Sector

1 Dr. Robert Lockman
Center for Naval Analysis
200 North Beauregard Street
Alexandria, VA 22311

1 Dr. Frederic M. Lord
Educational Testing Service
Princeton, NJ 08541

1 Dr. James Lumsden
Department of Psychology
University of Western Australia
Nedlands, Western Australia 6009
AUSTRALIA

1 Dr. Gary Marco
Stop 31-E
Educational Testing Service
Princeton, NJ 08541

1 Dr. Scott Maxwell
Department of Psychology
University of Notre Dame
Notre Dame, IN 46556

1 Dr. Samuel T. Mayo
Loyola University of Chicago
820 North Michigan Avenue
Chicago, IL 60611

1 Mr. Robert McKinley
American College Testing Programs
P.O. Box 168
Iowa City, IA 52243

1 Dr. Robert Mislevy
711 Illinois Street
Geneva, IL 60134

1 Dr. Allen Munro
Behavioral Technology Laboratories
1845 Elena Avenue, Fourth Floor
Redondo Beach, CA 90277
Private Sector

1 Dr. Alan Nicewander
University of Oklahoma
Department of Psychology
Oklahoma City, OK 73069

1 Dr. Donald A. Norman
Cognitive Science, C-015
University of California, San Diego
La Jolla, CA 92093

1 Dr. Melvin R. Novick
356 Lindquist Center for Measurement
University of Iowa
Iowa City, IA 52242

1 Dr. James Olson
WICAT, Inc.
1875 S. State Street
Orem, UT 84057

1 Dr. Wayne M. Patience
American Council on Education
GED Testing Service, Suite 20
One Dupont Circle, NW
Washington, DC 20036

1 Dr. James A. Paulson
Portland State University
P.O. Box 751
Portland, OR 97207

1 Dr. James W. Pellegrino
University of California, Santa Barbara
Department of Psychology
Santa Barbara, CA 93106

1 Dr. Mark D. Reckase
ACT
P.O. Box 168
Iowa City, IA 52243

1 Dr. Lauren Resnick
LRDC
University of Pittsburgh
3939 O'Hara Street
Pittsburgh, PA 15261

Private Sector

1 Dr. Thomas Reynolds
University of Texas, Dallas
Marketing Department
P.O. Box 688
Richardson, TX 75080

1 Dr. Andrew Rose
American Institutes for Research
1055 Thomas Jefferson St., NW
Washington, DC 20007

1 Dr. Ernst Z. Rothkopf
Bell Laboratories
Murray Hill, NJ 07974

1 Dr. Lawrence Rudner
403 Elm Avenue
Takoma Park, MD 20012

1 Dr. J. Ryan
Department of Education
University of South Carolina
Columbia, SC 29208

1 Prof. Fumiko Samejima
Department of Psychology
University of Tennessee
Knoxville, TN 37916

1 Dr. Walter Schneider
Psychology Department
603 E. Daniel
Champaign, IL 61820

1 Dr. Lowell Schoer
Psychological and Quantitative Foundations
College of Education
University of Iowa
Iowa City, IA 52242

1 Dr. Robert J. Seidel
Instructional Technology Group
HUNRRO
300 N. Washington Street
Alexandria, VA 22314
Private Sector

1 Dr. Kazuo Shigemasu
University of Tohoku
Department of Educational Psychology
Kawauchi, Sendai 980
JAPAN

1 Dr. Edwin Shirkey
Department of Psychology
University of Central Florida
Orlando, FL 32816

1 Dr. William Sims
Center for Naval Analysis
200 North Beauregard Street
Alexandria, VA 22311

1 Dr. H. Wallace Sinaiko
Program Director
Nanpower Research and Advisory Services
Smithsonian Institution
801 North Pitt Street
Alexandria, VA 22314

1 Dr. Richard Snow
School of Education
Stanford University
Stanford, CA 94305

1 Dr. Kathryn T. Spoehr
Psychology Department
Brown University
Providence, RI 02912

1 Dr. Robert Sternberg
Department of Psychology
Yale University
Box 11A, Yale Station
New Haven, CT 06520

1 Dr. Peter Stoloff
Center for Naval Analysis
200 North Beauregard Street
Alexandria, VA 22311

Private Sector

1 Dr. William Stout
University of Illinois
Department of Mathematics
Urbana, IL 61801

1 Dr. Patrick Suppes
Institute for Mathematical Studies in the Social Sciences
Stanford University
Stanford, CA 94305

1 Dr. Hariharan Swaminathan
Laboratory of Psychometric and Evaluation Research
School of Education
University of Massachusetts
Amherst, MA 01003

1 Dr. Kikumi Tatsuoka
Computer Based Education Research Laboratory
252 Engineering Research Laboratory
University of Illinois
Urbana, IL 61801

1 Dr. Maurice Tatsuoka
220 Education Building
1310 S. Sixth Street
Champaign, IL 61820

1 Dr. David Thissen
Department of Psychology
University of Kansas
Lawrence, KS 66044

1 Dr. Douglas Towne
University of Southern California
Behavioral Technology Labs
1845 S. Elena Avenue
Redondo Beach, CA 90277

1 Dr. Robert Tsutsakawa
Department of Statistics
University of Missouri
Columbia, MO 65201
Private Sector

1 Dr. V. R. R. Uppuluri
Union Carbide Corporation
Nuclear Division
P.O. Box Y
Oak Ridge, TN 37830

1 Dr. David Vale
Assessment Systems Corporation
2233 University Avenue
Suite 310
St. Paul, MN 55114

1 Dr. Kurt Van Lehn
Xerox PARC
3333 Coyote Hill Road
Palo Alto, CA 94304

1 Dr. Howard Wainer
Educational Testing Service
Princeton, NJ 08541

1 Dr. Michael T. Waller
Department of Educational Psychology
University of Wisconsin
Milwaukee, WI 53201

1 Dr. Brian Waters
HUMRRO
300 North Washington
Alexandria, VA 22314

1 Dr. Phyllis Weaver
2979 Alexis Drive
Palo Alto, CA 94304

1 Dr. David J. Weiss
N660 Elliott Hall
University of Minnesota
75 East River Road
Minneapolis, MN 55455

1 Dr. Keith T. Wescourt
Perceptronics, Inc.
545 Middlefield Road
Suite 140
Menlo Park, CA 94025

Private Sector

1 Dr. Rand R. Wilcox
University of Southern California
Department of Psychology
Los Angeles, CA 90007

1 Dr. Wolfgang Wildgrube
Streitkraefteamt
Box 20 50 03
D-5300 Bonn 2
WEST GERMANY

1 Dr. Bruce Williams
Department of Educational Psychology
University of Illinois
Urbana, IL 61801

1 Dr. Wendy Yen
CTB/McGraw-Hill
Del Monte Research Park
Monterey, CA 93940